AGS Booster Issues

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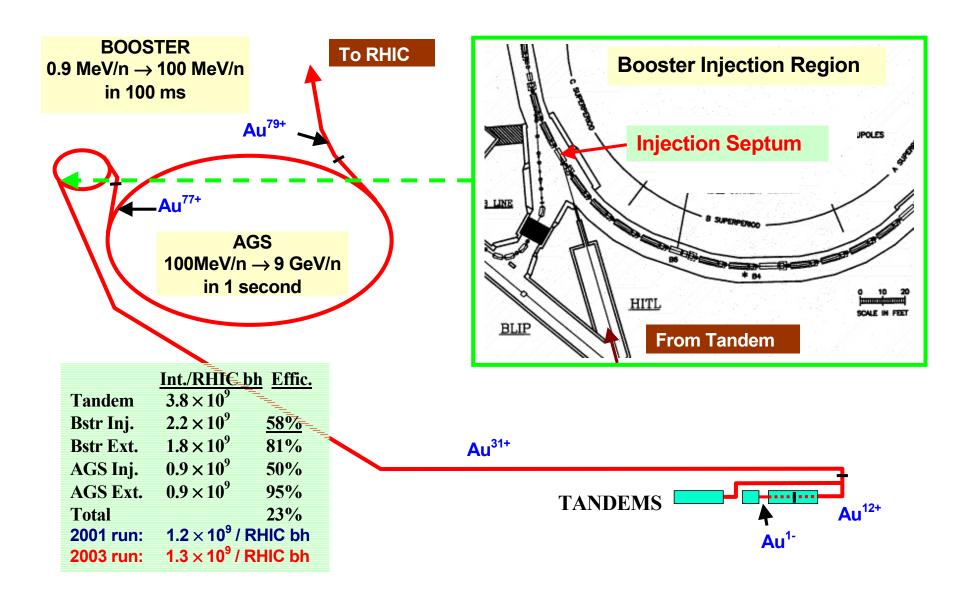
Brookhaven National Laboratory

- 1. RHIC Heavy Ion Injector Complex
- 2. Beam Loss Mechanism at the Booster Injection
 - Capture loss for Au 31+ ions
- 3. Vacuum Pressure Measurement at the Booster Injection
 - Transient pressure rise with very high peak
- 4. Two Tandem Beam Study
 - Dump first beam within 100 ms affects second beam's lifetime
- 5. Gold Beam Loss Effect in the Booster Ring
 - Beam lifetime decreases after the beam scraping
- 6. Booster Injection Scrubbing Effect
 - Observed long term beam (sputtering) scrubbing effect
- 7. Gold Beam Scraping Study at the Injection Septum
 - Secondary electron and ion yield for gold beam loss
- 8. Tandem Study of Ions Scraping Effect
 - Secondary electron yield with glancing angle incident
- 9. Comments and Acknowledgment





1. RHIC Heavy Ion Injector Complex





Sections, cm²

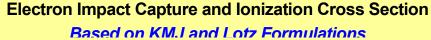


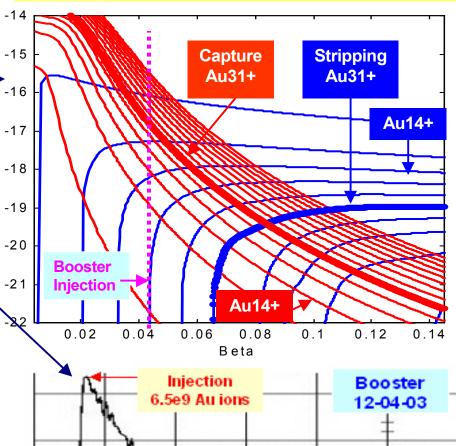
• Beam injected into Booster at 0.9 MeV/n, β = 0.044. Capture cross section (CS) is much larger than the stripping CS.

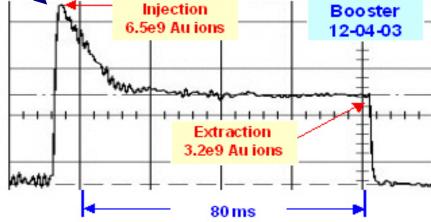
• In first 20 ms (to β = 0.08), the capture cross section is reduced by a factor of 100, consistent with the observed beam loss pattern.

 For Au 14+ injection, both capture and stripping took effect at the injection, later the stripping loss become dominant.

- Au 14+ beam loss took place in the entire acceleration period, in different loss pattern from Au 31+.
- Injection septum aperture fold correction in Run 4 leads to new high Booster exit, at 3.2e9 Au ions.



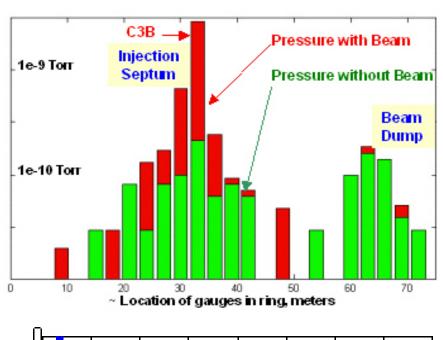


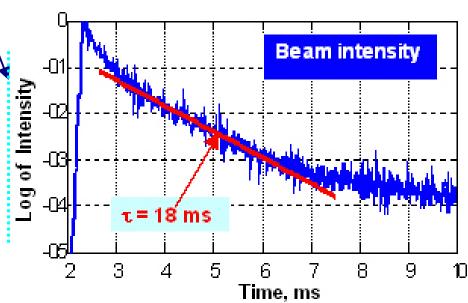




3. Pressure Measurement at the Booster Injection

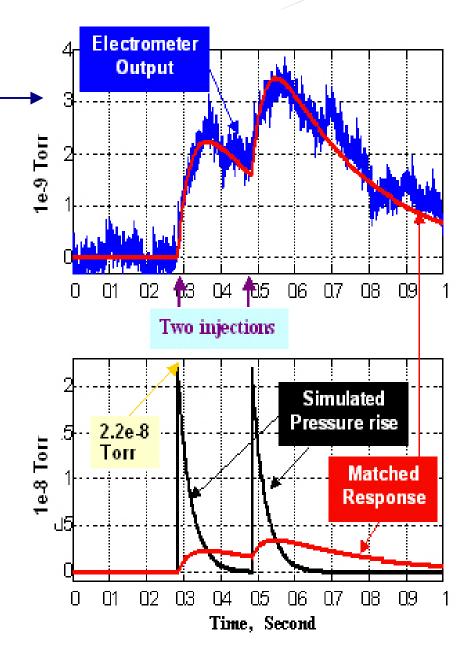
- Pressure rise at the Booster Au beam injection, highest at the exit of injection septum, C3B.
- Pressure rise spread in about 20 m, with the highest at 3e-9 Torr.
- Taking CO equivalent Au 31+ capture cross section of 2e-16 cm², the beam lifetime of 18 ms cannot be explained.
- The pressure rise of 3e-9 Torr is the vacuum gauge measurement averaged every 3 second.
- At 1e-11 Torr level, the ion gauge's signal is in pA's, whereas noise signal may reach nA.
- Vacuum pressure rise at the beam injection was measured by using electrometer to read ion gauge directly.







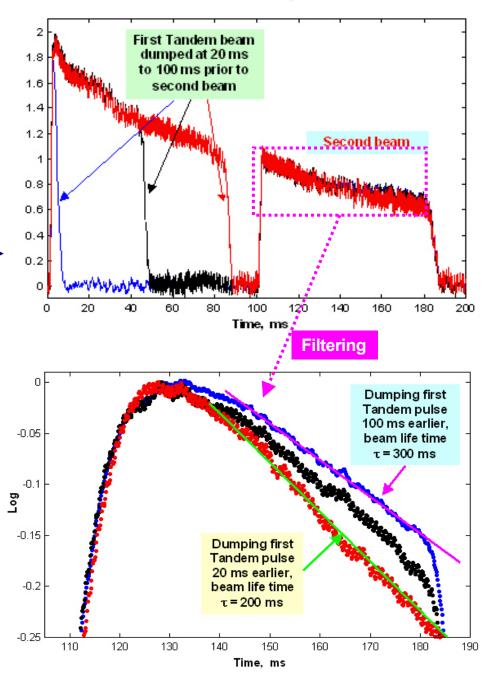
- Simulation using electrometer transfer function shows that with 0.5e9 Au 31+ ions lost, peak pressure rise reaches 2.2e-8 Torr.
- The pressure rise reported was ~
 2e-10 Torr. The real peak pressure rise is a factor of 100 higher.
- Using the simulated pressure rise, at high intensity injection, the beam lifetime is 20 to 50 ms.
- The resulting ion desorption rate is about 100,000.
- Equally important is that pressure decay time constant is 35 ms at low intensity, and 70 ms at high intensity.
- Consistent with the observation: the second Tandem beam injected 200 ms later is usually not affected by the first one.





4. Two Tandem Beam Study

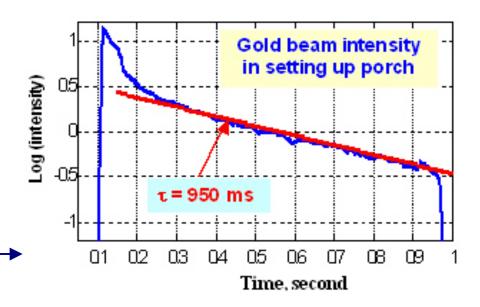
- Using 600 Gauss porch at the Booster, inject two Tandem beams, without ramping.
- Two injections were separated by 100 ms. Dump first beam in Booster in different time to observe the lifetime of the second beam.
- Cesium replenishment at the ion source was insufficient, so direct comparison of two injections was impossible.
- The beam lifetime of the second injection was affected by the first beam dumped < 100 ms earlier, not otherwise.
- This shows that the lost ions in the ring affect the beam lifetime through pressure rise.

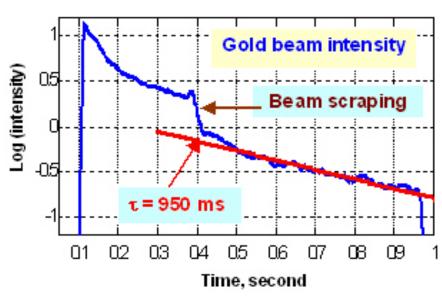




5. Gold Beam Loss Effect in the Booster Ring

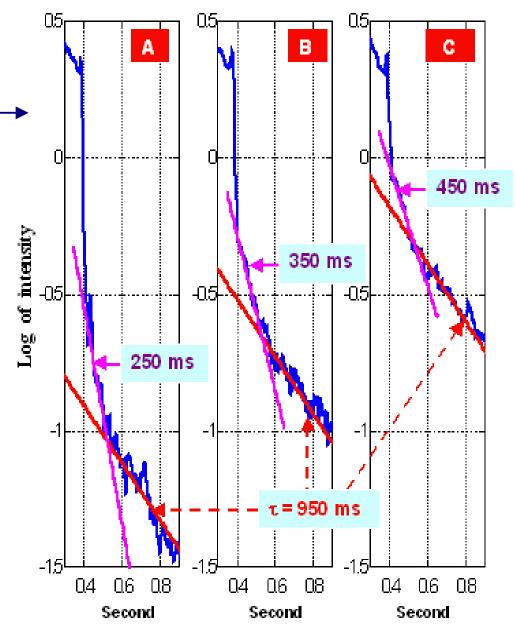
- Using a 1 second long, 800
 Gauss flat porch
 - Beam energy becomes 1.6 MeV/n, with β = 0.058.
 - Capture cross section is reduced to 1/10.
 - Beam lifetime extended to 950 ms.
- Orbit bumps were used to scrape the beam on the wall, in several locations. Beam intensity was 1e9 Au 31+ ions.
- Beam scraped horizontally and vertically, difference was small.
- Beam lifetime was significantly decreased immediately after the beam scraping, then recovered to 950 ms.
- 3 cases in scraping study.







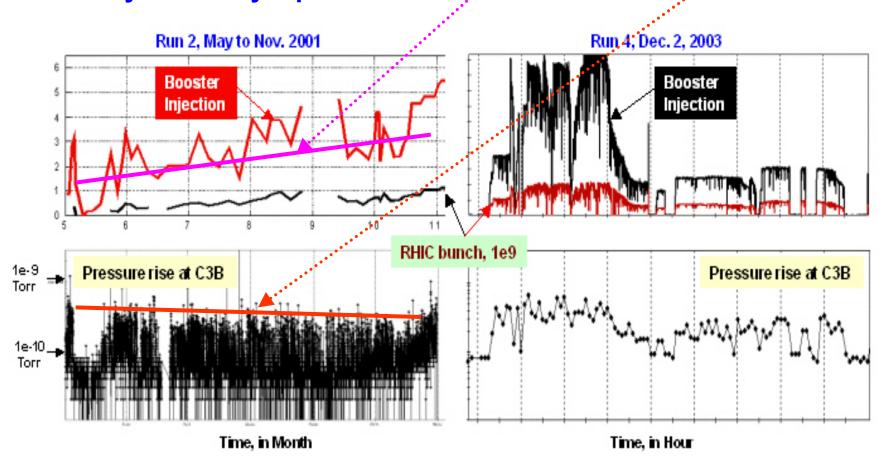
- Beam loss and beam lifetime immediately followed the scraping in 3 cases are
 - **A.** 3.1e 8 ions, τ = 250 ms.
 - **B.** 2.3e 8 ions, τ = 350 ms.
 - **C.** 1.5e 8 ions, τ = 450 ms.
- In all cases, the beam lifetime was affected in a period of 100 ms, consistent with the pressure decay time constant of 35 ms.
- Assuming the scraping produced pressure rise in 20 m long pipe, then the pressure rises and the ion desorption rates are
 - **A.** $\Delta P = 3.4e-8$ Torr, $\eta = 1.09e6$.
 - **B.** $\Delta P = 2.5e-8$ Torr, $\eta = 1.03e6$.
 - C. $\triangle P = 1.9e-8 \text{ Torr}, \eta = 1.21e6.$
- The desorption rates are larger than the ones at the septum study, better beam scraping?





6. Booster Injection Scrubbing Effect

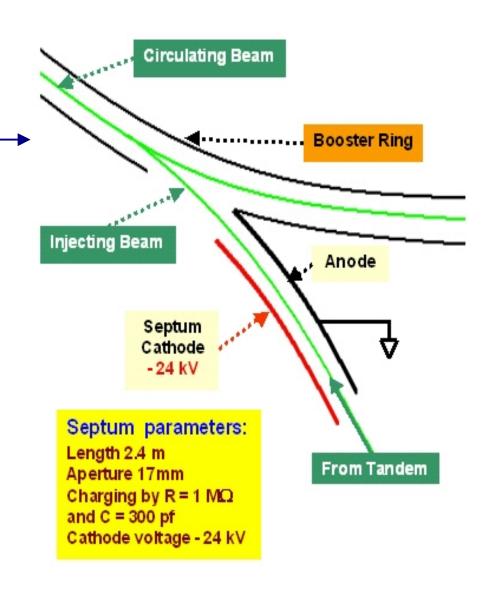
- Booster injection area scrubbing effect has been observed in long terms of time period.
- In Run 2, the Booster injection intensity increased in a period of a few months, the pressure rise at the exit of injection septum decreased.
- In Run 4, after the improvement at the septum aperture, the injection efficiency is already equivalent to the later Run 2 and Run 3.





7. Gold Beam Scraping Study at the Injection Septum

- Pressure rise of ~ 20 m long at the beam injection centered at the exit of septum.
- Voltage of septum cathode is used to measure the beam scraping effect. The charging time constant is 0.3 ms, not too small.
- Conventional method is the electron collection.
- Beam FWHM size is 4 mm, and septum aperture is 17 mm.
- SE production depends on
 - Projectile' energy, 0.9 MeV/n is at the production peak.
 - Projectile' charge state, usually $a \sim q^2$ dependence.
 - Incident angle effect, usually a 1/cosθ dependence.



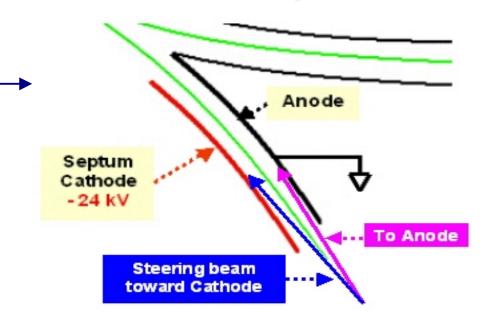


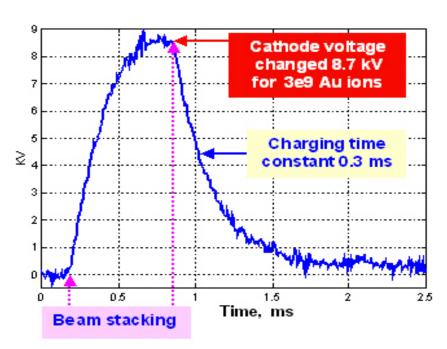
Secondary electron production

- Steering beam for ~ 1 mm toward the cathode, a 8.7 kV voltage rise was observed.
- The charging time constant is consistent with 0.3 ms.
- With about 0.6e9 ions lost at the scraping, secondary electron yield per lost ion is ~100,000.
- Electron depletion taking effect at the later stacking.

Secondary ion production

- By steering beam toward the anode, >2 kV voltage rise at the cathode was observed.
- Secondary electrons will stay, but secondary ions will go to the cathode.
- Secondary ions (charge)
 production rate is about 20,000
 per lost ion.



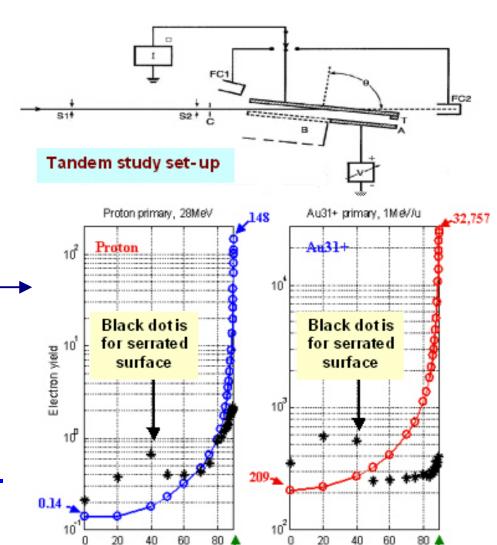




8. Tandem Study of lons scraping Effect

- The SE production with different incident angles measured at the Tandem, using biased target, rather than to collect electrons,
 - H⁺ ions, 28 MeV.
 - O⁸⁺ ions, 7.9 MeV/n.
 - Au³¹⁺ ions, 0.9MeV/n.
- Proton, oxygen and gold ions scraping have been measured up to 89.96 degrees.
- SE production rate approximately matches the relation of $1/\cos\theta$.
- Serrated surface significantly reduced SEY at the glancing angle.
- TiN coated surface also studied, the results posed question for the reduction of SEY with ions impact.

A.L. Hanson et al. J. Vac. Sci. Tech. A 19(5), 2001



P. Thieberger et al. Physical Review A, V.61, 2000

scraping

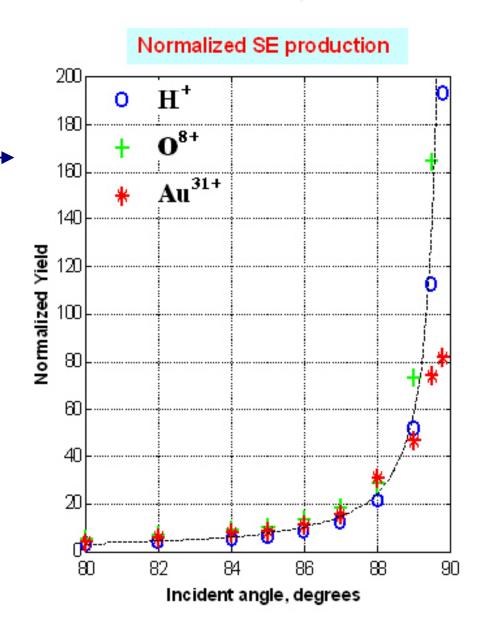
Angle(degree)

Angle(degree)

scraping



- Secondary electron yield is normalized by projectile peak production energy, at perpendicular incident angle, and the charge state 1.
 - Seiler's model is used for the projectile energy dependence, with the peak production energy at 500 eV electrons, or ions with 0.9 MeV/n.
 - The charge state dependence is better matched to $q^{1.6}$.
 - The incident angle dependence is better matched to $1/(\cos \theta)^{1.25}$.
- Proton and oxygen ions yields are matched up to 89.9 degrees, but gold ions SEY started to peak at 89.5 degrees, electron depletion taking effect?





9. Comments and Acknowledgment

Comments

- Many SEY measurements at glancing angles reported maxima at 70° to 85°.
- Some explanations, although bearing truth, may have missed dominant factors.
- If confirmed, Booster and Tandem studies have shown that 1/cosθ factor extends to very close to 90°.
- The glancing angle ion desorption measurement is more difficult than the SEY measurement.
- Ion desorption measurement is still to be done, if you look at this. →

Acknowledgment

Thanks to L. Ahrens, J.M. Brennan, C. Gardner, H.C. Hseuh, T. Roser, D. Steski, P. Thieberger, and K. Zeno.

- 1. Ion beam may be deflected from the target surface by a mechanism similar to planar channeling in crystals. [Physical Review B]
- Close to 90 degree the collision cascades are located so close to surface that they are not fully developed. [Physical Review B]
- 3. Electron depletion. [NIM B]

	1981	1991
	Sputtering by Particle Bombardment I	Sputtering by Particle Bombardment III
Yield	1-5	1-20
Energy max	5-50 keV	5-500 keV
Angle max	to 80 deg.	to 85 deg.

Sputtering by Particle Bombardment, Springer-Verlag

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